

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination HANADA ET AL.	
		Examiner Victor S Chang	Art Unit 1771	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,183,863	02-2001	Kawachi et al.	428/355AC
	B	US-			
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	D	US-			
	E	US-			
	F	US-			
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	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N	JP 2001113654 A	04-2001	Japan	NODONO et al.	B32B 27/32
	O					
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	R					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	English Abstract of JP 2001113654A (see above for auther, title, and date).
	V	Computer translation of JP 2002-266511. Date: 06-2002; Country: Japan; Name: Hanada et al.
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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